

<b>Notice of References Cited</b>	Application/Control No. 10/583,639		Applicant(s)/Patent Under Reexamination MIYAKE, HIDETOMO	
	Examiner KEITH T. AZIZ		Art Unit 1791	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,040,525	05-2006	Lee et al.	228/49.5
*	B	US-7,102,726	09-2006	Byun et al.	349/189
*	C	US-6,893,311	05-2005	Lee et al.	445/24
*	D	US-2003/0164934	09-2003	Nishi et al.	355/72
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2000147528 A	05-2000	Japan	EGAMI et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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